

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/813,616	SMITH, ANTHONY DAVID KIN	
Examiner		Art Unit		Page 1 of 1
Alan S. Chen		2182		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0225796 A1	11-2004	Hanson et al.	710/301
*	B	US-6,886,083 B2	04-2005	Murakami, Masatoshi	711/156
*	C	US-6,234,389 B1	05-2001	Valliani et al.	235/380
*	D	US-5,463,772 A	10-1995	Thompson et al.	707/101
*	E	US-6,078,968 A	06-2000	Lo et al.	710/5
*	F	US-2003/0085289 A1	05-2003	Kaneko, Yoshio	235/492
*	G	US-6,823,398 B1	11-2004	Lee et al.	710/5
*	H	US-6,871,245 B2	03-2005	Bradley, Mark W.	710/65
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.